

MOSFET – N-Channel, UltraFET Trench

220 V, 7.0 A, 366 m Ω

FDMC2674

General Description

UltraFET device combines characteristics that enable benchmark efficiency in power conversion applications. Optimized for $R_{DS(on)}$, low ESR, low total and Miller gate charge, these devices are ideal for high frequency DC to DC converters.

Features

- Max $R_{DS(on)} = 366 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 1.0 \text{ A}$
- Typ $Q_g = 12.7 \text{ nC}$ at $V_{GS} = 10 \text{ V}$
- Low Miller Charge
- Low Q_{rr} Body Diode
- Optimized Efficiency at High Frequencies
- UIS Capability (Single Pulse and Repetitive Pulse)
- Pb-Free, Halide Free and RoHS Compliant

Applications

- DC-DC Converters and Off-Line UPS
- Distributed Power Architectures

MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
V _{DS}	Drain to Source Voltage	220	V
V _{GS}	Gate to Source Voltage	±20	V
I _D		7.0 1.0 13.8	Α
E _{AS}	Single Pulse Avalanche Energy (Note 3)	11	mJ
P _D	Power Dissipation: T _C = 25°C T _A = 25°C (Note 1a)	42 2.1	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range	–55 to +150	°C

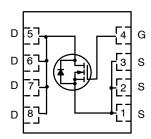
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

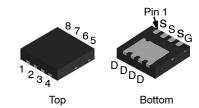
Symbol	Parameter	Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case (Note 1)	3.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	60	

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V _{DS}	R _{DS(ON)} MAX	I _D MAX
220 V	366 mΩ @ 10 V	7.0 A



N-CHANNEL MOSFET



WDFN8 3.3 × 3.3, 0.65P CASE 511DH

MARKING DIAGRAM

FDMC 2674 ALYW O

FDMC2674 = Specific Device Code
A = Assembly Site
L = Wafer Lot Number
YW = Assembly Start Week

ORDERING INFORMATION

Device	Package	Shipping [†]
FDMC2674	WDFN8 (Pb–Free, Halide Free)	3000 / Tape & Reel

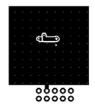
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
FF CHARA	ACTERISTICS		•		•	
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	220	-	-	V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	_	248	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 176 V, V _{GS} = 0 V	1 –	-	1	μΑ
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V	_	-	±100	nA
N CHARA	CTERISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2	3.4	4	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	_	-10.2	-	mV/°C
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 1.0 A	_	305	366	mΩ
		V _{GS} = 10 V, I _D = 1.0 A, T _J = 150°C	_	678	814	
YNAMIC C	HARACTERISTICS		•		•	
C _{iss}	Input Capacitance	V _{DS} = 100 V, V _{GS} = 0 V, f = 1 MHz	_	880	1180	pF
C _{oss}	Output Capacitance		_	70	95	pF
C _{rss}	Reverse Transfer Capacitance		_	11	20	pF
WITCHING	CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	V_{DD} = 100 V, I_{D} = 1.0 A, V_{GS} = 10 V, R_{GEN} = 2.4 Ω	_	9	18	ns
t _r	Rise Time	$V_{GS} = 10 \text{ V, } R_{GEN} = 2.4 \Omega$	_	13	23	ns
t _{d(off)}	Turn-Off Delay Time		_	15	27	ns
t _f	Fall Time		_	21	34	ns
Q _{g(TOT)}	Total Gate Charge at 10 V	V _{GS} = 0 V to 10 V, V _{DD} = 15 V, I _D = 1.0 A	-	12.7	18	nC
Q _{gs}	Gate to Source Gate Charge	V _{DD} = 15 V, I _D = 1.0 A	_	3.8	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{DD} = 15 V, I _D = 1.0 A	i -	2.9	_	nC
DRAIN-SOU	RCE DIODE CHARACTERISTICS					
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.2 A (Note 2)	_	0.8	1.5	V
t _{rr}	Reverse Recovery Time	I _F = 1.0 A, di/dt = 100 A/μs	<u> </u>	-	60	ns
Q _{rr}	Reverse Recovery Charge	1	_	_	109	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² oz copper pad on a 1.5 × 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.
 - (a) $R_{\theta JA} = 60^{\circ}\text{C/W}$ when mounted on a 1 in² pad of 2 oz copper, 1.5' × 1.5' × 0.062' thick PCB.
 - (b) $R_{\theta JA} = 135^{\circ} C/W$ when mounted on a minimum pad of 2 oz copper.



a) 60°C/W when mounted on a 1 in² pad of 2 oz copper.



b) 135°C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3. Starting $T_J = 25$ °C; N-ch: L = 1 mH, $I_{AS} = 4.7$ A, $V_{DD} = 25$ V, $V_{GS} = 10$ V.

TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

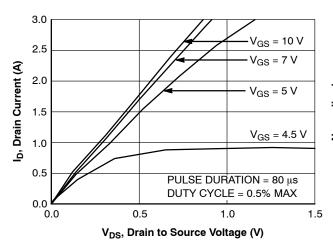


Figure 1. On-Region Characteristics

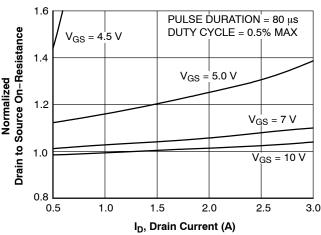


Figure 2. Normalized On–Resistance vs. Drain Current and Gate Voltage

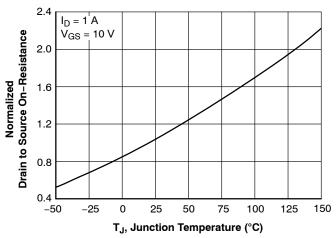


Figure 3. Normalized On–Resistance vs. Junction Temperature

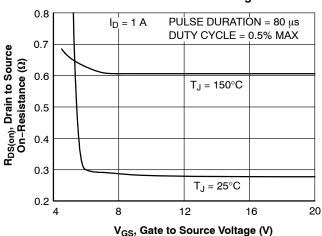


Figure 4. On-Resistance vs. Gate to Source Voltage

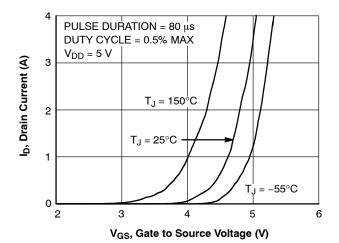


Figure 5. Transfer Characteristics

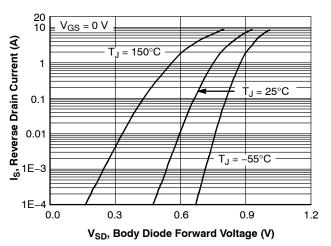
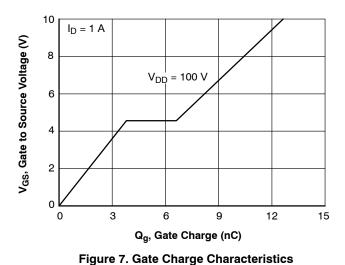


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (continued)

(T_J = 25°C unless otherwise noted)



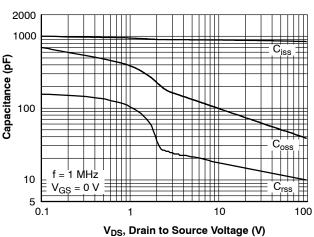


Figure 8. Capacitance vs. Drain to Source

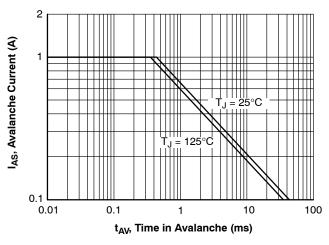


Figure 9. Unclamped Inductive Switching Capability

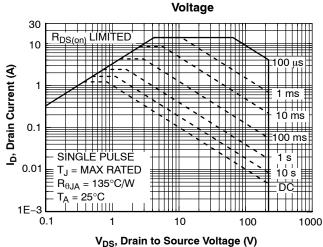


Figure 10. Forward Bias Safe Operating Area

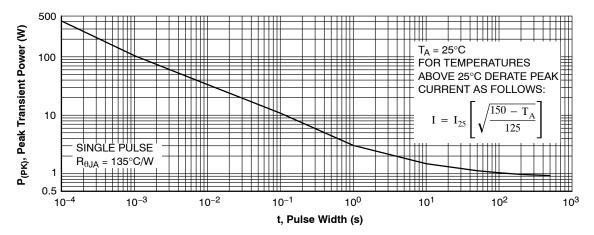


Figure 11. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

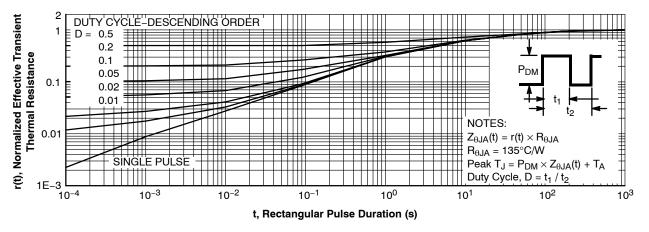
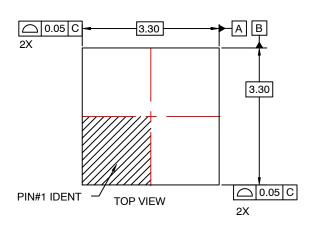
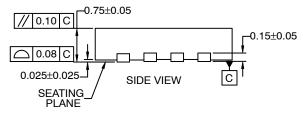


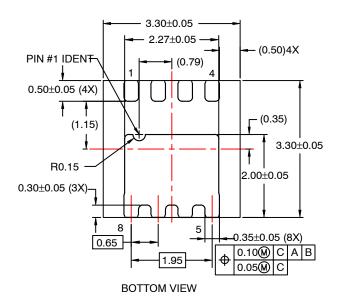
Figure 12. Transient Thermal Response Curve

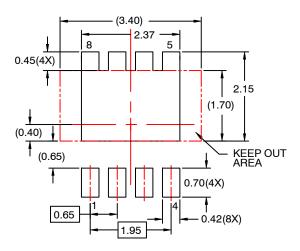
WDFN8 3.3x3.3, 0.65P CASE 511DH ISSUE O

DATE 31 JUL 2016









RECOMMENDED LAND PATTERN

NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

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